FAIRCHILD

SEMICONDUCTOR

FQB9N50C/FQI9N50C 500V N-Channel MOSFET

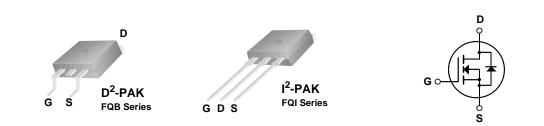
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

Features

- 9 A, 500V, $R_{DS(on)} = 0.8 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 28 nC)
- Low Crss (typical 24 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB9N50C/FQI9N50C	Units	
V _{DSS}	Drain-Source Voltage		500	V	
I _D	Drain Current - Continuous (T _C = 25°C)	9	А	
	- Continuous (T _C = 100°	C)	5.4	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	36	Α	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	360	mJ	
I _{AR}	Avalanche Current	(Note 1)	9	А	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	13.5	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns	
PD	Power Dissipation (T _C = 25°C) - Derate above 25°C		135	W	
			1.07	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

Thermal Characteristics

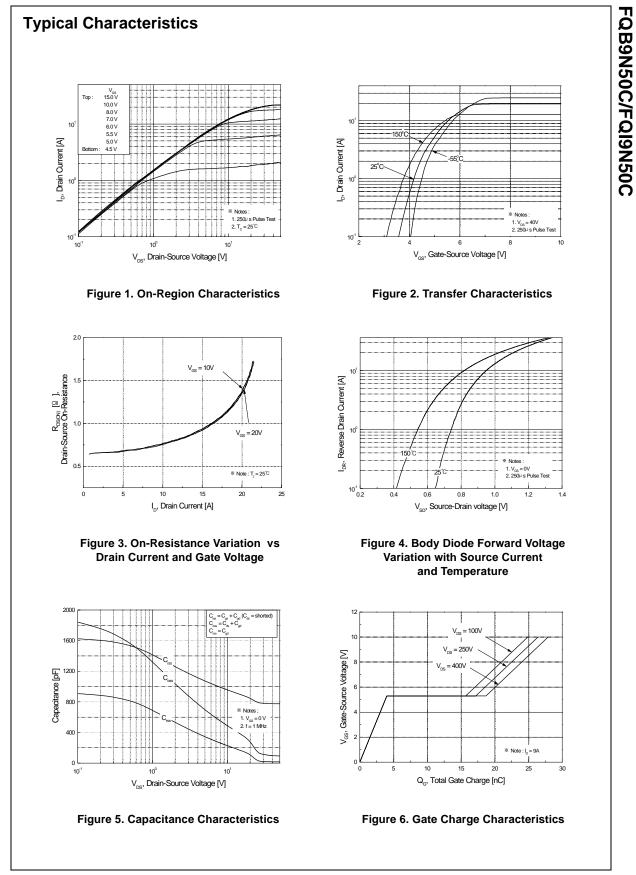
Symbol	Parameter	Тур	Max	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		0.93	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient *		40	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

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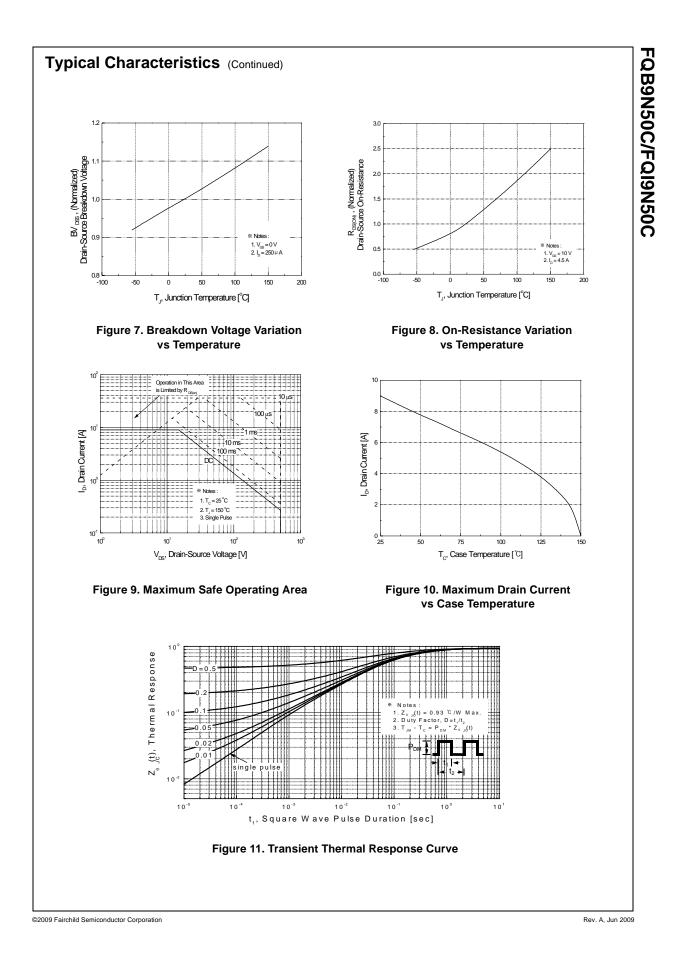
FET[™]

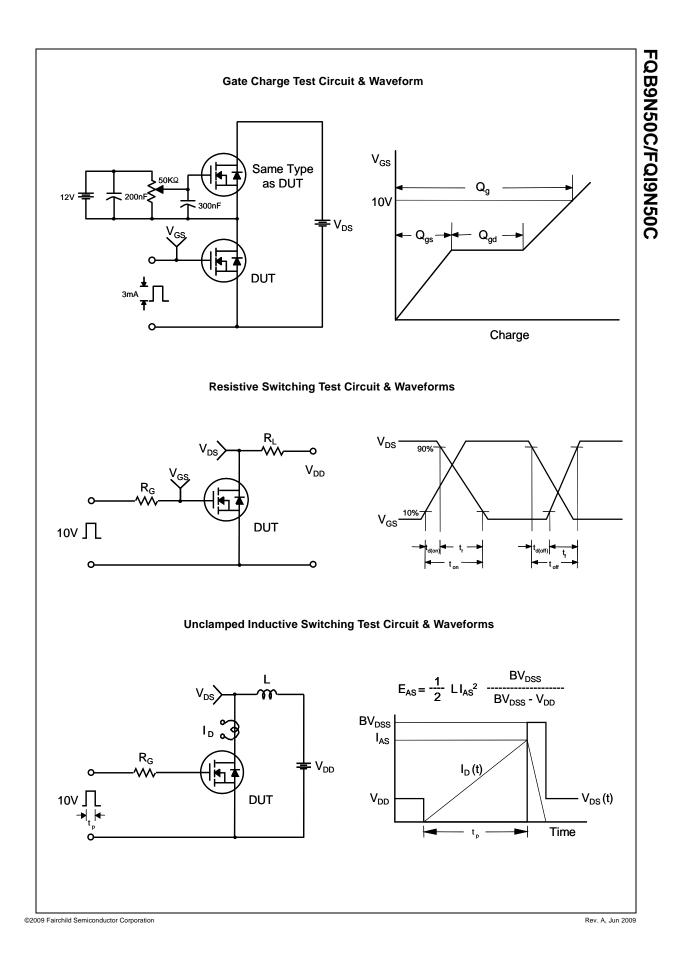
off Cha	Parameter	Test Conditions	Min	Тур	Max	Units
	raatariatiaa					
	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	500			V
VDSS BV _{DSS}	Breakdown Voltage Temperature		500			
ΔT_{J}	Coefficient	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$		0.57		V/°C
SS	Zero Gate Voltage Drain Current	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	μΑ
	Zero Gale Voltage Brain Gurrent	$V_{DS} = 400 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			10	μΑ
SSF	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
SSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
n Cha	racteristics					
GS(th)	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
DS(on)	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 4.5 A		0.65	0.8	Ω
s	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_{D} = 4.5 \text{ A}$ (Note 4)		6.5		S
-						
	c Characteristics	Ι	1			
SS	Input Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V,$		790	1030	pF
DSS	Output Capacitance	f = 1.0 MHz		130	170	pF
rss	Reverse Transfer Capacitance			24	30	pF
witchi	ng Characteristics					
(on)	Turn-On Delay Time			18	45	ns
(on)	Turn-On Rise Time	$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 9 \text{ A},$		65	140	ns
(off)	Turn-Off Delay Time	R _G = 25 Ω		93	195	ns
(011)	Turn-Off Fall Time	(Note 4, 5)		64	125	ns
	Total Gate Charge	V _{DS} = 400 V, I _D = 9 A,		28	35	nC
a	-	$V_{GS} = 10 V$		4		nC
•	Gate-Source Charge					
g gs gd	Gate-Source Charge Gate-Drain Charge	(Note 4, 5)		15		nC
^{gs} gd Prain-So	Gate-Drain Charge ource Diode Characteristics ar Maximum Continuous Drain-Source Dio	(Note 4, 5) And Maximum Ratings ade Forward Current			9	A
gs gd Prain-So M	Gate-Drain Charge ource Diode Characteristics ar Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	(Note 4, 5) The Maximum Ratings ade Forward Current Forward Current			1	
gs gd prain-Se M SD	Gate-Drain Charge ource Diode Characteristics ar Maximum Continuous Drain-Source Dio	(Note 4, 5) nd Maximum Ratings de Forward Current Forward Current $V_{GS} = 0 V, I_S = 9 A$	 		9	A
gs gd Prain-So	Gate-Drain Charge ource Diode Characteristics ar Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	(Note 4, 5) The Maximum Ratings ade Forward Current Forward Current	 		9 36	A

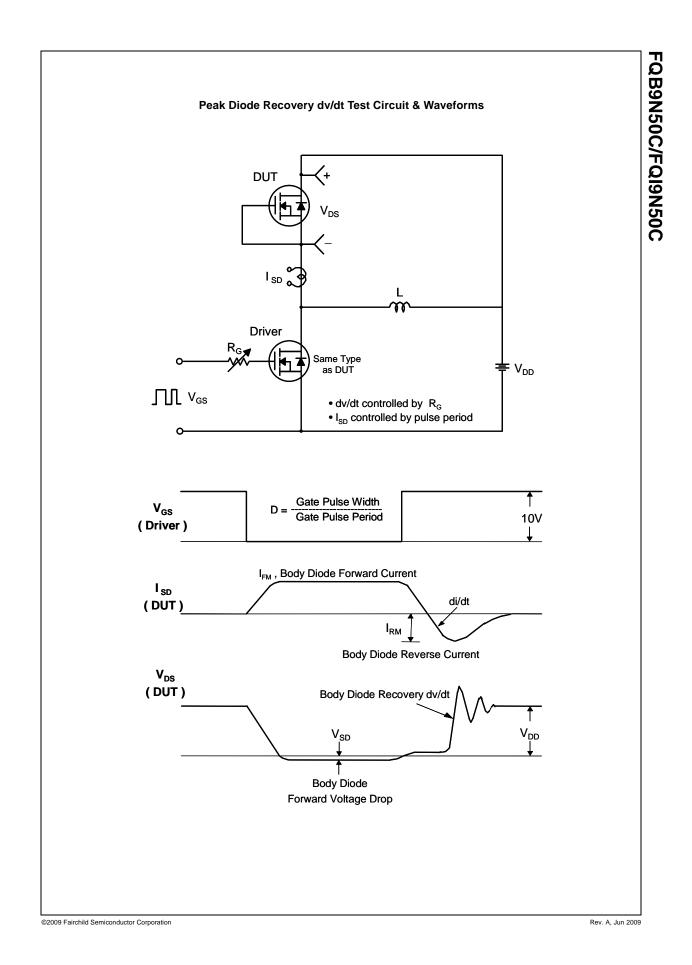
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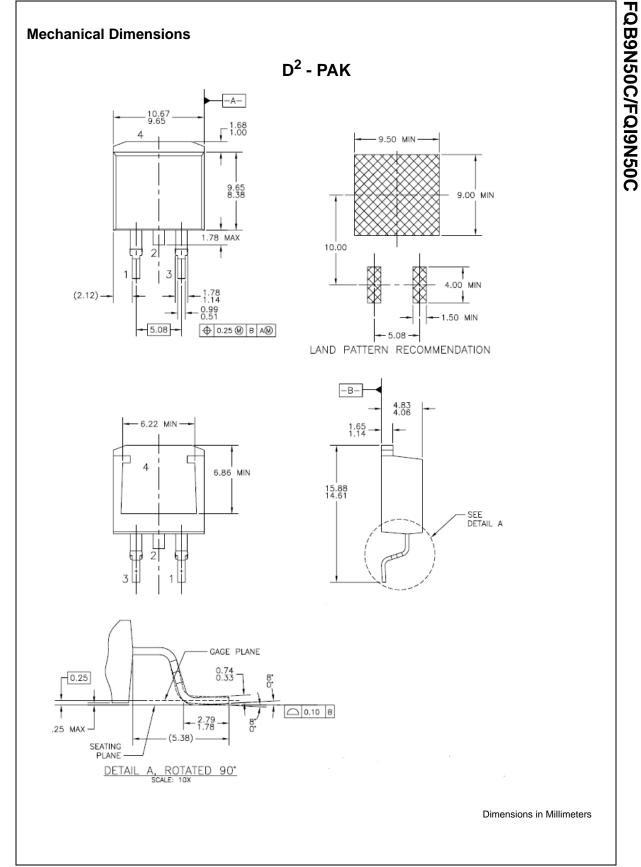
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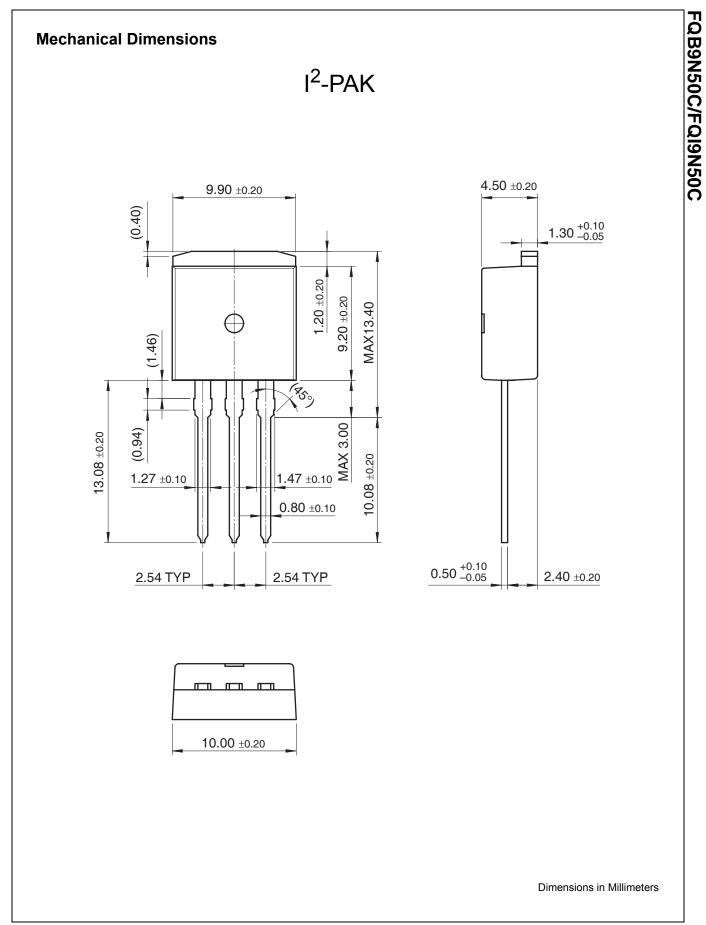




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